# FDD6670A

March 2015



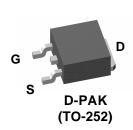
# 30V N-Channel PowerTrench<sup>o</sup> MOSFET

### **General Description**

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low  $R_{DS(ON)}$ , fast switching speed and extremely low  $R_{DS(ON)}$  in a small package.

# Applications

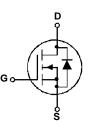
- DC/DC converter
- Motor Drives



# Features

• 66 A, 30 V 
$$R_{DS(ON)} = 8 \text{ m}\Omega @ V_{GS} = 10 \text{ V}$$
  
 $R_{DS(ON)} = 10 \text{ m}\Omega @ V_{GS} = 4.5 \text{ V}$ 

- Low gate charge
- Fast Switching
- + High performance trench technology for extremely low  $R_{\text{DS}(\text{ON})}$



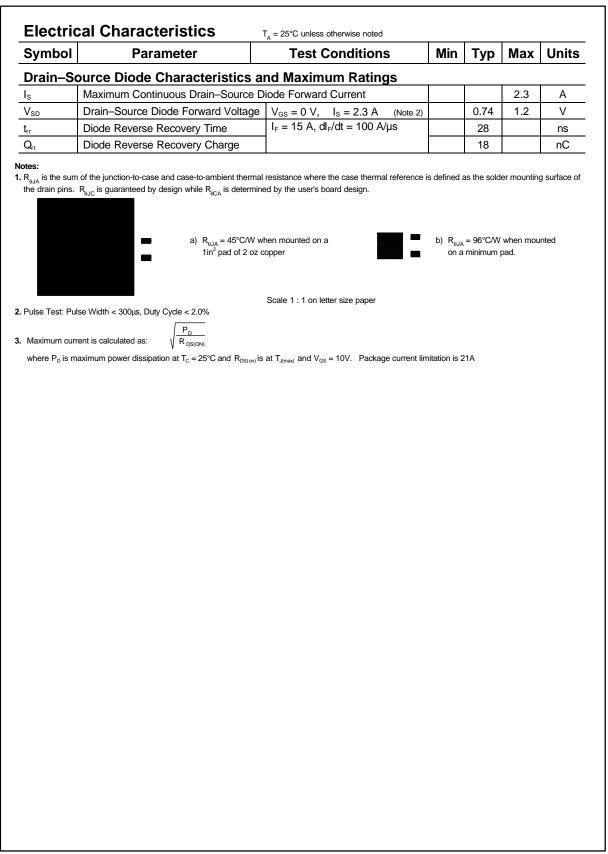
# Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

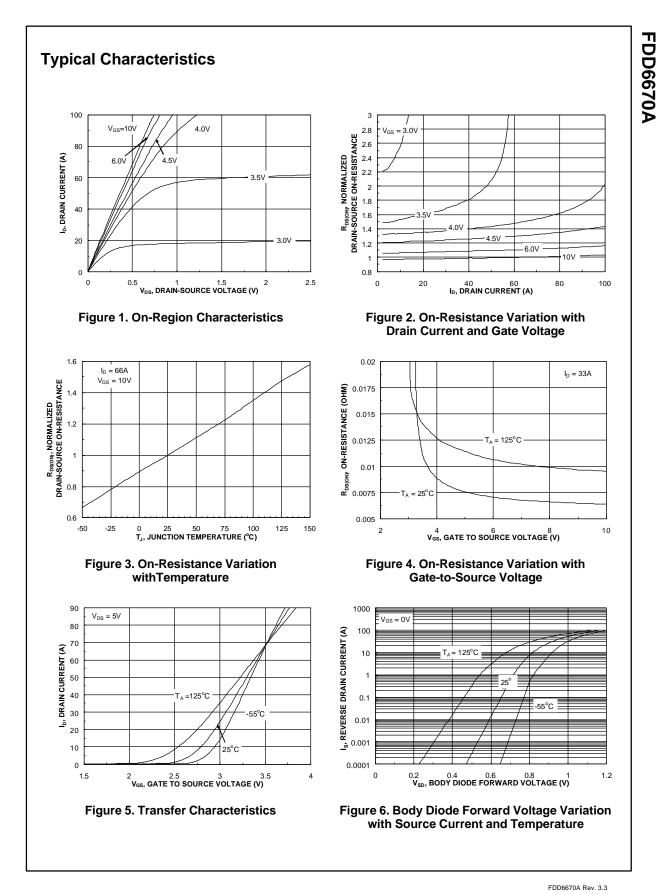
Symbol	Para	Parameter			Ratings		nits
V <sub>DSS</sub>	Drain-Source Voltage	ce Voltage		30			V
V <sub>GSS</sub>	Gate-Source Voltage	ce Voltage			±20		V
l <sub>D</sub>	Continuous Drain Current	t @T <sub>c</sub> =25°C	(Note 3)		66		А
		@T <sub>A</sub> =25°C	(Note 1a)		15		
		Pulsed	(Note 1a)		100		
P <sub>D</sub>	Power Dissipation	@T <sub>c</sub> =25°C	(Note 3)		63		W
		@T <sub>A</sub> =25°C	(Note 1a)		3.2		
		@T <sub>A</sub> =25°C	(Note 1b)		1.3		
T <sub>J</sub> , T <sub>S⊺G</sub>	Operating and Storage Ju	and Storage Junction Temperature Range			-55 to +175		
Therma	I Characteristics						
R <sub>eJC</sub>	Thermal Resistance, Jun	nal Resistance, Junction-to-Case (Note 1)			2.4		
R <sub>eja</sub>	Thermal Resistance, Jun	esistance, Junction-to-Ambient (Note 1a)			40		
R <sub>eja</sub>		(Note 1b)			96		
Packag	e Marking and Or	dering I	nformation	)			
	Marking Devic		Package	Reel Size	Tape width	Quant	ity
FDD6670A FDD667		70A D	-PAK (TO-252)	13"	16mm	2500 u	nits

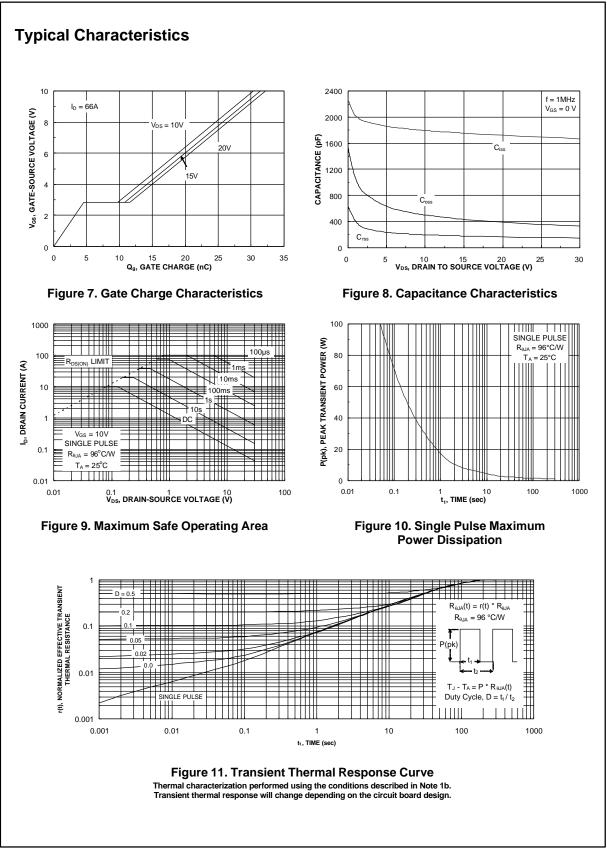
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Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Drain-Sc	burce Avalanche Ratings (Not	te 2)				
AS	Drain-Source Avalanche Energy	Single Pulse, $V_{DD} = 15 \text{ V}$ , $I_D = 66 \text{ A}$			67	mJ
AS	Drain-Source Avalanche Current				66	Α
Off Char	racteristics					
3V <sub>DSS</sub>	Drain–Source Breakdown Voltage	$V_{GS} = 0 V$ , $I_D = 250 \mu A$	30			V
Δ <mark>BV</mark> <sub>DSS</sub> ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 µA,Referenced to 25°C		26		mV/°C
DSS	Zero Gate Voltage Drain Current	$V_{\text{DS}} = 24 \text{ V}, \qquad V_{\text{GS}} = 0 \text{ V}$			1	μA
GSS	Gate–Body Leakage	$V_{\text{GS}} = \pm 20 \text{ V},  V_{\text{DS}} = 0 \text{ V}$			±100	nA
On Char	acteristics (Note 2)					
/ <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, \qquad I_D = 250 \ \mu A$	1	1.8	3	V
$\Delta V_{GS(th)}$ $\Delta T_J$	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}, \text{Referenced to } 25^{\circ}\text{C}$		-5		mV/°C
R <sub>DS(on)</sub>	Static Drain–Source	$V_{GS} = 10 \text{ V},  I_{D} = 15 \text{ A}$		6.3	8	mΩ
	On Provintence	$V_{GS} = 4.5 \text{ V},  I_D = 13 \text{ A}$		7.9	10	
	On–Resistance			9.5	13	
D(on)	On-State Drain Current	$V_{GS} = 10 \text{ V}, I_D = 15 \text{ A}, T_J = 125^{\circ}\text{C}$	50	9.5	13	A
			50	9.5 60	13	A S
FS	On–State Drain Current Forward Transconductance		50		13	
9⊧s Dynamic	On–State Drain Current Forward Transconductance Characteristics	$ \begin{array}{l} V_{GS} = 10 \ V, \ I_{D} = 15 \ A, T_{J} = 125^{\circ}C \\ V_{GS} = 10 \ V, \ V_{DS} = 5 \ V \\ V_{DS} = 10 \ V, \ I_{D} = 15 \ A \end{array} $	50		13	S
D <sub>FS</sub> Dynamic C <sub>iss</sub>	On–State Drain Current Forward Transconductance	$\begin{split} V_{GS} &= 10 \ V, \ I_D = 15 \ A, T_J = 125^\circ C \\ V_{GS} &= 10 \ V, \ V_{DS} = 5 \ V \\ V_{DS} &= 10 \ V, \ I_D = 15 \ A \\ \end{split}$	50	60	13	
C <sub>iss</sub> C <sub>oss</sub>	On–State Drain Current Forward Transconductance Characteristics Input Capacitance	$ \begin{array}{l} V_{GS} = 10 \ V, \ I_{D} = 15 \ A, T_{J} = 125^{\circ}C \\ V_{GS} = 10 \ V, \ V_{DS} = 5 \ V \\ V_{DS} = 10 \ V, \ I_{D} = 15 \ A \end{array} $	50	60 1755	13	S pF
Des Dynamic C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	On–State Drain Current Forward Transconductance C Characteristics Input Capacitance Output Capacitance	$\begin{split} V_{GS} &= 10 \ V, \ I_D = 15 \ A, T_J = 125^\circ C \\ V_{GS} &= 10 \ V, \ V_{DS} = 5 \ V \\ V_{DS} &= 10 \ V, \ I_D = 15 \ A \\ \end{split}$	50	60 1755 430	13	S pF pF
DFS <b>Dynamic</b> Diss Coss Crss Rg	On–State Drain Current Forward Transconductance C Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance	$\begin{split} V_{GS} &= 10 \ V, \ I_D &= 15 \ A, T_J = 125^\circ C \\ V_{GS} &= 10 \ V, \ V_{DS} &= 5 \ V \\ V_{DS} &= 10 \ V, \ I_D &= 15 \ A \\ \end{split}$	50	60 1755 430 180		S pF pF pF
DFS Dynamic Diss Coss Crss Crss Coss Crss Coss Crss Coss Co	On–State Drain Current Forward Transconductance Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance	$\begin{split} V_{GS} &= 10 \ V, \ I_D &= 15 \ A, T_J = 125^\circ C \\ V_{GS} &= 10 \ V, \ V_{DS} &= 5 \ V \\ V_{DS} &= 10 \ V, \ I_D &= 15 \ A \\ \end{split}$		60 1755 430 180	20	S pF pF pF
Ders Dynamic Cliss Clis	On–State Drain Current Forward Transconductance C Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance	$\begin{split} V_{GS} &= 10 \ V, \ I_D &= 15 \ A, T_J = 125^\circ C \\ V_{GS} &= 10 \ V, \ V_{DS} &= 5 \ V \\ V_{DS} &= 10 \ V, \ I_D &= 15 \ A \\ \end{split}$		60 1755 430 180 1.3		S pF pF Ω
Dynamic Dynamic Criss Criss Rg Switchir	On–State Drain Current Forward Transconductance Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance gCharacteristics (Note 2) Turn–On Delay Time	$\begin{array}{l} V_{GS} = 10 \ V, \ I_{D} = 15 \ A, T_{J} = 125^{\circ}C \\ V_{GS} = 10 \ V, \ V_{DS} = 5 \ V \\ V_{DS} = 10 \ V, \ I_{D} = 15 \ A \\ \end{array}$		60 1755 430 180 1.3 11	20	S pF pF Ω ns
DFS Dynamic Ciss Coss Crss Crss Crss Crss Crss Crss Cr	On-State Drain Current Forward Transconductance Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance gCharacteristics (Note 2) Turn-On Delay Time Turn-On Rise Time	$\begin{array}{l} V_{GS} = 10 \ V, \ I_{D} = 15 \ A, T_{J} = 125^{\circ}C \\ \hline V_{GS} = 10 \ V, \ V_{DS} = 5 \ V \\ \hline V_{DS} = 10 \ V, \ I_{D} = 15 \ A \\ \hline \end{array}$		60 1755 430 180 1.3 11 12	20 21	S pF pF Ω ns ns
DFS Dynamic Ciss Coss Crss R G Switchir a(on) r a(off)	On–State Drain Current Forward Transconductance Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance Definition Delay Time Turn–On Rise Time Turn–On Rise Time	$\begin{array}{l} V_{GS} = 10 \ V, \ I_{D} = 15 \ A, T_{J} = 125^{\circ}C \\ \hline V_{GS} = 10 \ V, \ V_{DS} = 5 \ V \\ \hline V_{DS} = 10 \ V, \ I_{D} = 15 \ A \\ \hline \end{array}$		60 1755 430 180 1.3 11 12 29	20 21 47	S pF pF Ω ns ns ns
DFS <b>Dynamic</b> C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub> R <sub>G</sub>	On–State Drain Current Forward Transconductance Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance <b>g Characteristics</b> (Note 2) Turn–On Delay Time Turn–On Rise Time Turn–Off Delay Time Turn–Off Fall Time	$\begin{array}{l} V_{GS} = 10 \ V, \ I_{D} = 15 \ A, T_{J} = 125^{\circ}C \\ \hline V_{GS} = 10 \ V, \ V_{DS} = 5 \ V \\ \hline V_{DS} = 10 \ V, \ I_{D} = 15 \ A \\ \hline \end{array}$		60 1755 430 180 1.3 11 12 29 19	20 21 47 34	S pF pF Ω ns ns ns

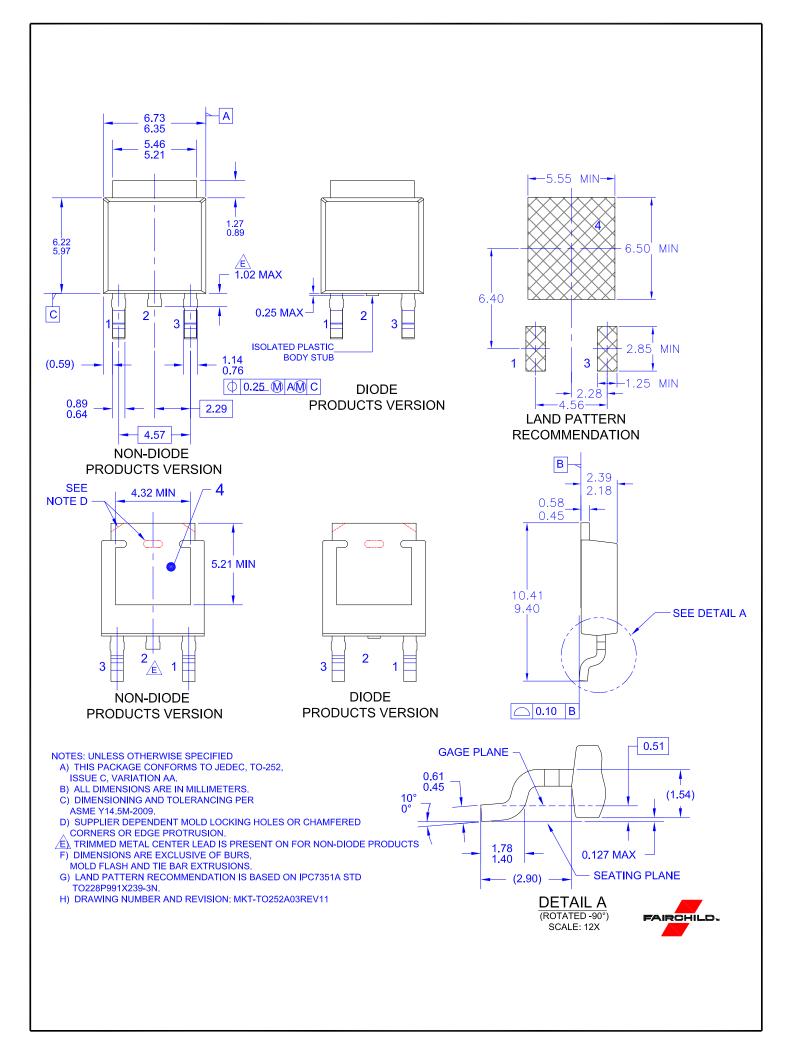
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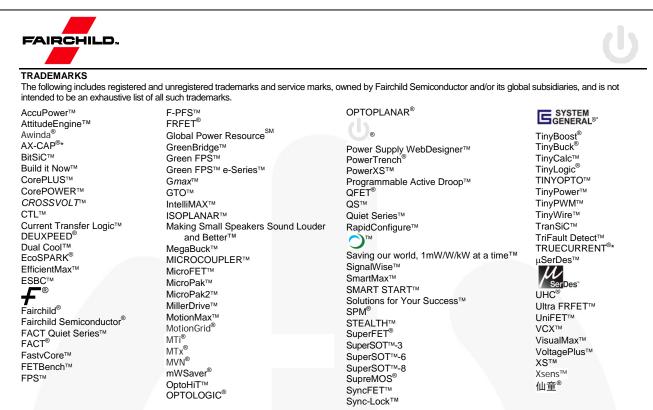






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